


<b>Search Notes</b>  	<b>Application/Control No.</b>  10519846	<b>Applicant(s)/Patent Under Reexamination</b>  KIM ET AL.
	<b>Examiner</b>  DARREN B SCHWARTZ	<b>Art Unit</b>  2435

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Limited class/subclass search (713/150,726/26) with keywords (see search history)	4/7/2008	DS
keywords search (see search history)	4/7/2008	DS
Updated search (see search history)	10/20/2008	DS
class/subclass search (380; 455; 713; 726) with keywords (see search history)	2/23/2009	DS
keywords search (see search history)	2/23/2009	DS
class/subclass search (726/26-30) with keywords (see search history)	8/1/2009	DS
keywords search (see search history)	8/1/2009	DS
keywords search (see search history)	1/2/2010	DS
EIC2400 STIC search (see search history)	1/2/2010	DS
Updated search (see search history)	5/8/2010	DS
Updated search (see search history)	9/24/2010	DS
class/subclass search (726/26-30) with keywords (see search history)	1/28/2011	DS
keywords search (see search history)	1/28/2011	DS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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